

Notice of References Cited	Application/Control No. 10/710,843	Applicant(s)/Patent Under Reexamination LIN ET AL.	
	Examiner Jae Lee	Art Unit 2823	Page 1 of 1

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*	B	US-2005/0218414 A1	10-2005	Ueda et al.	257/094
*	C	US-2006/0175621 A1	08-2006	Ohtsuka et al.	257/088
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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